Issue Classification

Application/Control No.	Applicant(s)/Patent Under Reexamination
10032885	LI ET AL.
Examiner	**Art Unit**
Nano, Sargon N	2157

ORIGINAL						INTERNATIONAL CLASSIFICATION									
CLASS			SUBCLASS			CLAIMED					NON-CLAIMED				
709			225			G	0	6	F	15 / 173	G	0	6	F	15 / 16
CROSS REFERENCE(S)											B	4	1	J	15 / 00
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)														
709	217	223													
358	1.9	1.16													

Sargon N. Nano	3/1/07	ZARNI MAUNG SUPERVISORY PATENT EXAMINER	Total Claims Allowed: 18
(Assistant Examiner)	(Date)		
SN	4-12-07	4/12/07.	O.G. Print Claim(s): 12 / O.G. Print Figure: 2
(Legal Instruments Examiner)	(Date)	(Primary Examiner) (Date)	